

## Sputtering of rough and nanostructured W samples

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**Jülich 06/02 – 09/02**

**Kickoff Meeting – WP PWIE 2023**

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MILANO 1863

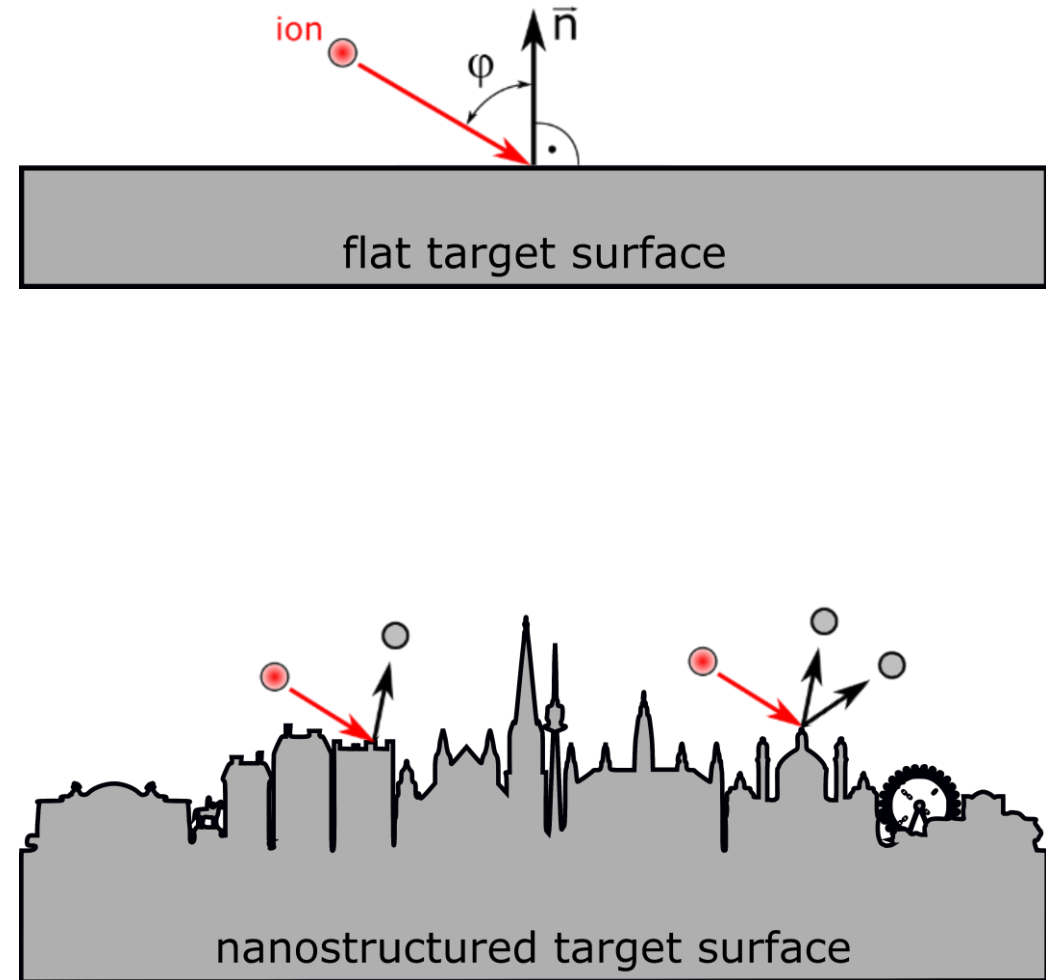
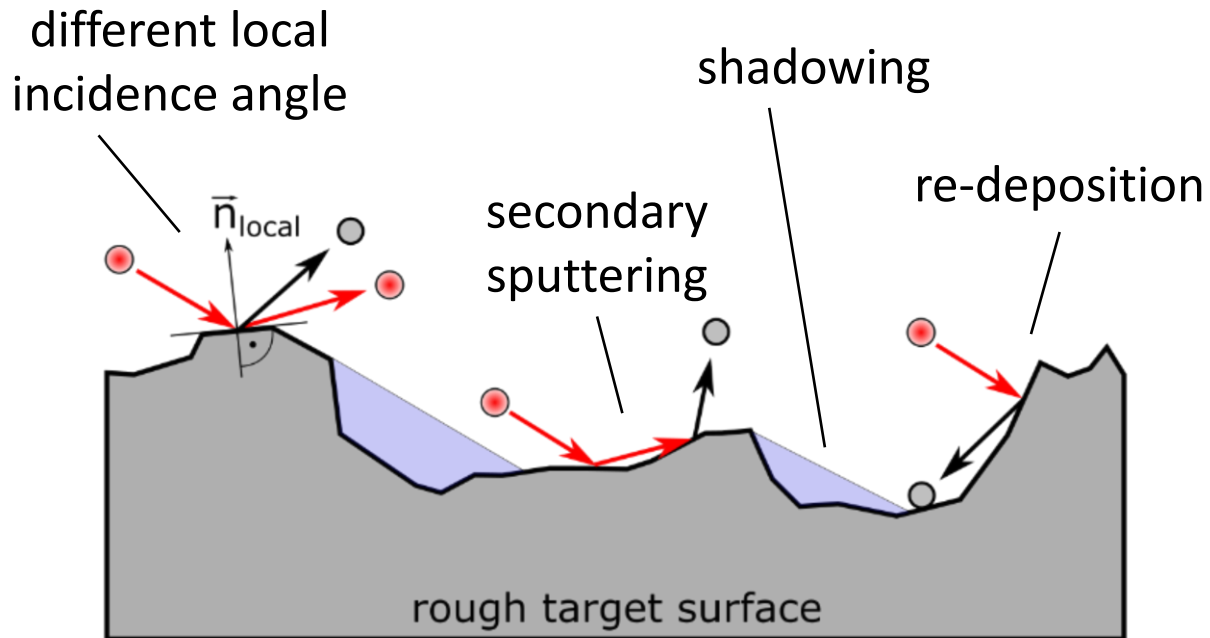


Gabriele Alberti,  
David Dellasega,  
Matteo Passoni,  
Matteo Pedroni,  
Andrea Uccello,  
Espedito Vassallo



HELSINGIN YLIOPISTO  
Alvaro Lopez-Cazalilla,  
Fredric Granberg,  
Kai Nordlund

# Sputtering of rough and nanostructured W samples

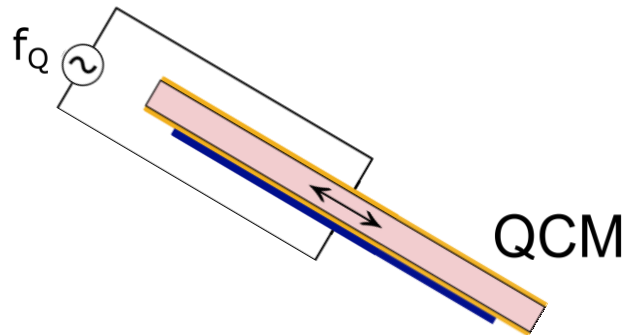


Introduction

**Experimental Approach**

Simulation Approach

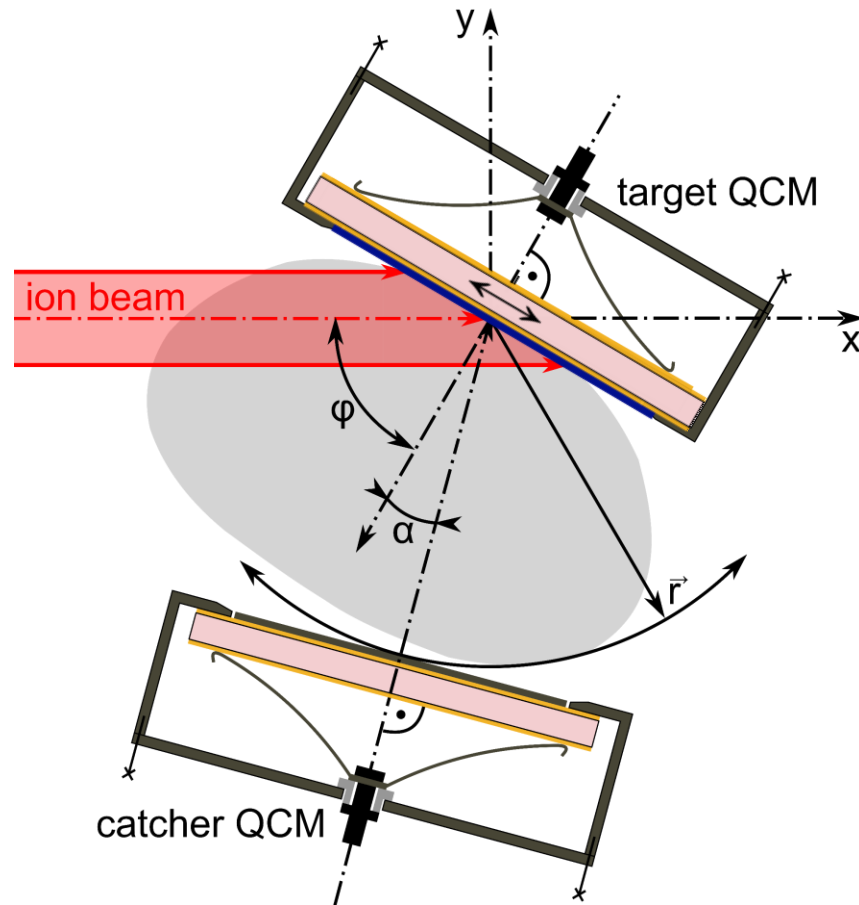
Selected Results and Outlook



- **Quartz Crystal Microbalance (QCM)**  
technique: detect mass changes *in-situ*

$$\frac{\Delta f_Q}{f_q} = - \frac{\Delta m_Q}{m_Q}$$

G. Sauerbrey, Zeitschrift f. Physik 155 (1959)



- **target erosion** experiments
- probing angular distribution of **sputtered particles**

- mass change rates down to  $10^{-9}$  g/cm<sup>2</sup>/s ( $\sim 10^{-4}$  W monolayers/s) can be detected
- for direct target erosion experiments: thin films deposited on QCM substrate can be investigated
- for catcher measurements: liberal sample choice possible, sputtered particles are collected with the catcher QCM

G. Hayderer et al., Rev. Sci. Instrum. 70 (1999)

B. M. Berger et al., Nucl. Instrum. Methods. Phys. Res. B 406 (2017)

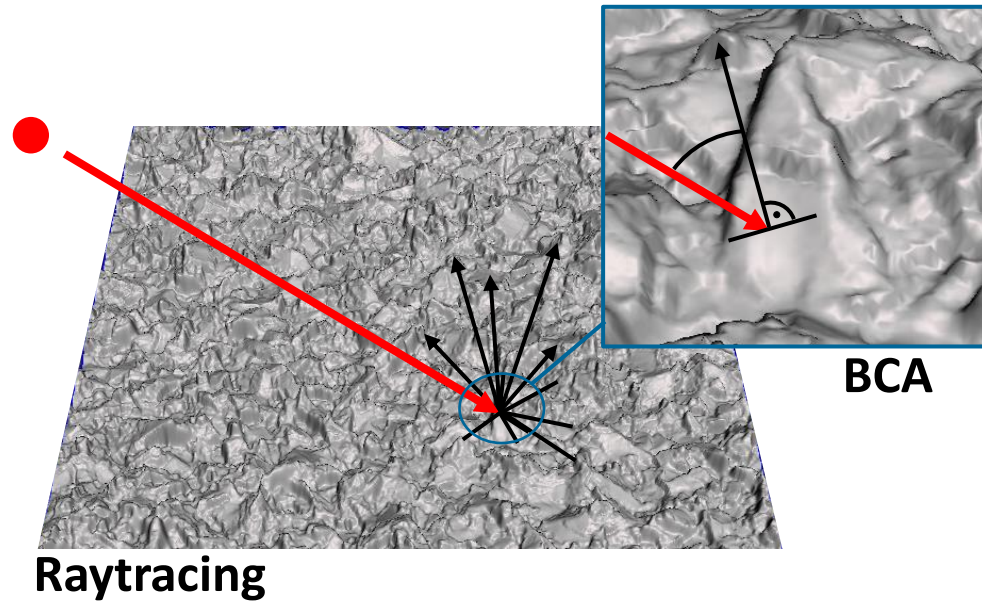
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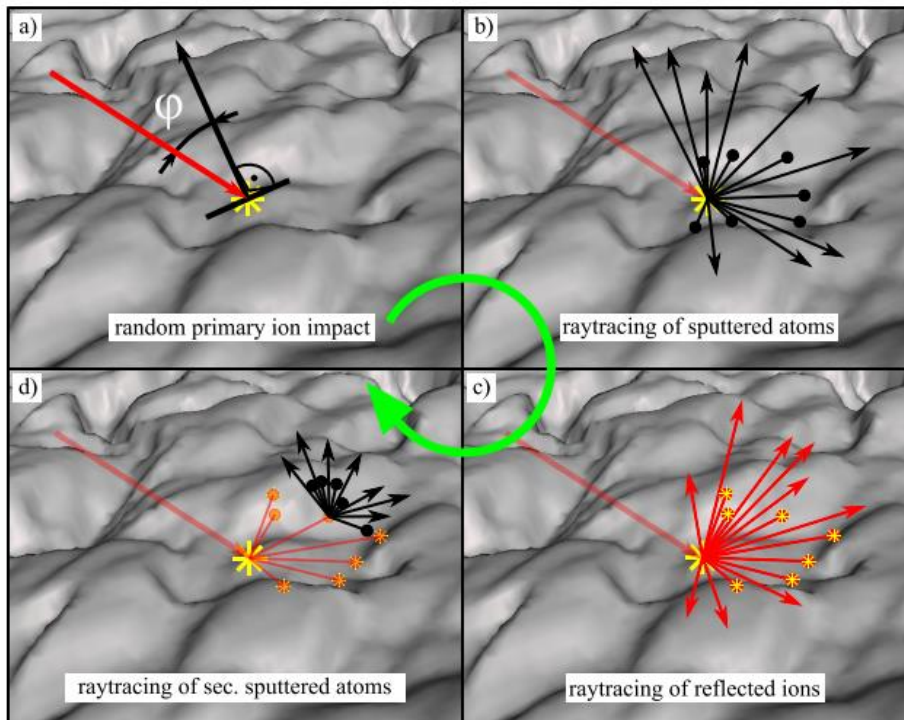
**SPRAY** = **SP**uttering simulation via **RAY**tracing of particles



- can be seen as an **add on** for available BCA codes like SDTrimSP
- utilizes flat **surface repository data from BCA codes**
- requires a **topography input** (e.g., from qualitative SEM images, quantitative AFM images, artificially generated structures, ...)
- performs a **raytracing loop**

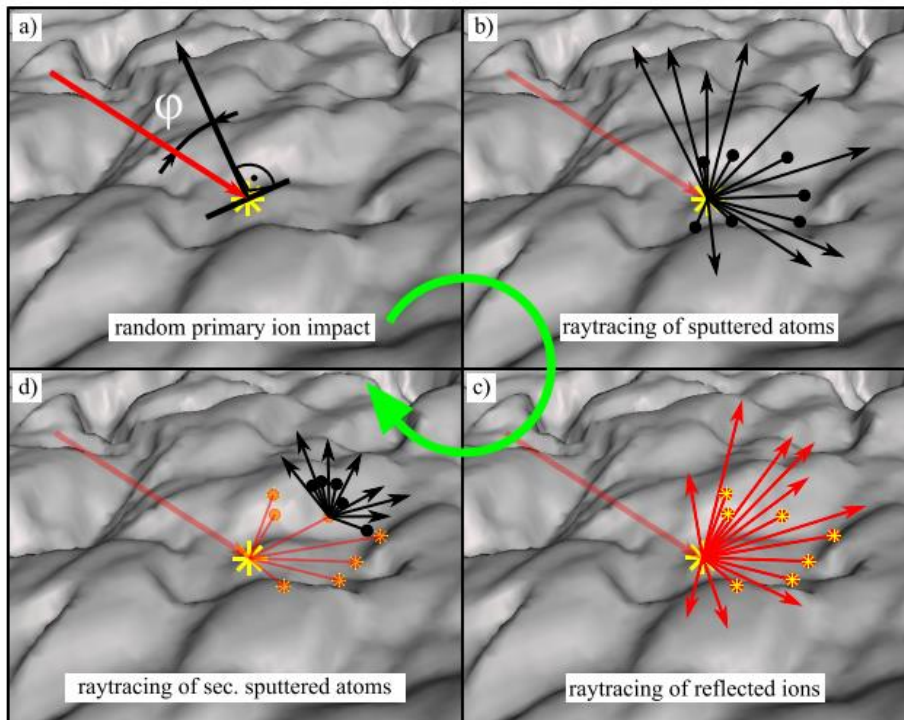


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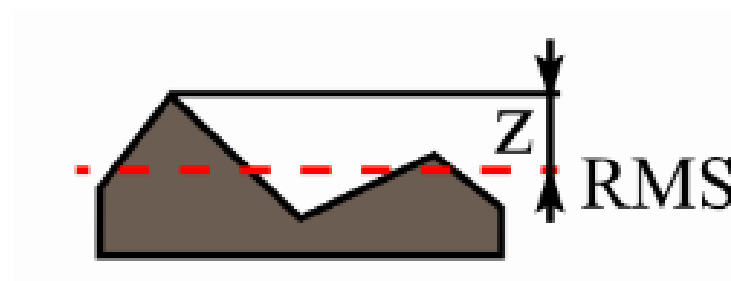
→ performs a **raytracing loop**

- a) ion randomly hits the surface – BCA repository
- b) sputtered atoms are ejected – redeposition
- c) ions get reflected – secondary impact
- d) secondary sputtering

**SPRAY** = **SP**uttering simulation via **RAY**tracing of particles

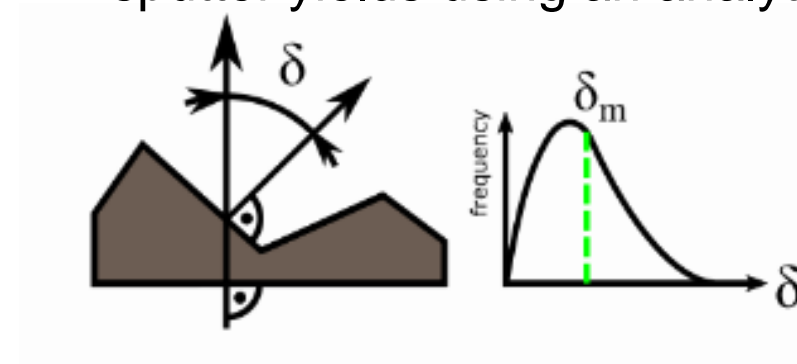
## root mean square roughness

→ scale dependent parameter,  
cannot predict sputter yields



## $\delta_m$ parameter

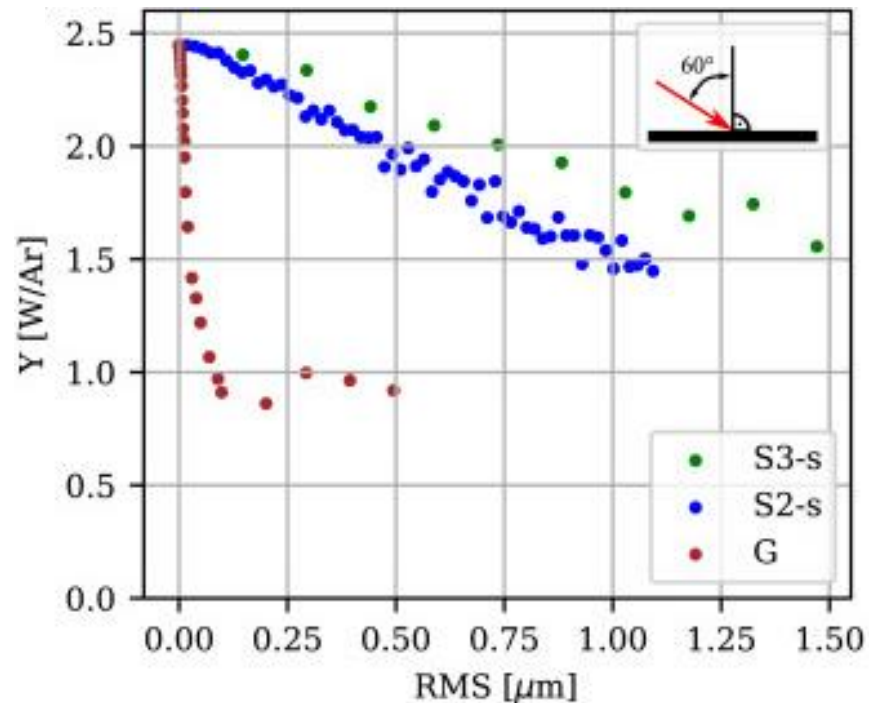
→ represents the mean inclination angle,  
scale independent, can be used to predict  
sputter yields using an analytical model



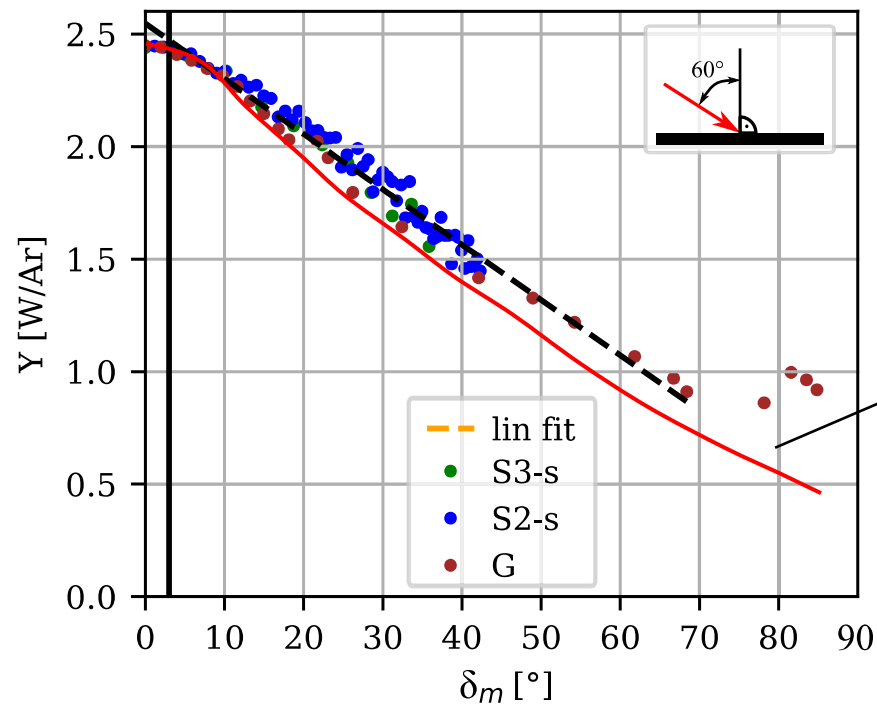
C. Cupak et al., Appl. Surf. Sci. 570 (2021)  
P. S. Szabo et al., Surf. Interfaces 30 (2022)

**SPRAY** = **SP**uttering simulation via **RAY**tracing of particles

root mean square roughness



$\delta_m$  parameter



analytical  
model

C. Cupak et al.,  
Appl. Surf. Sci. 570 (2021)  
P. S. Szabo et al.,  
Surf. Interfaces 30 (2022)

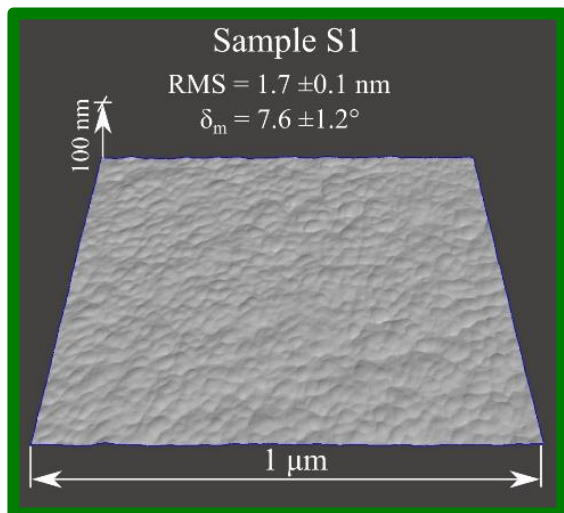
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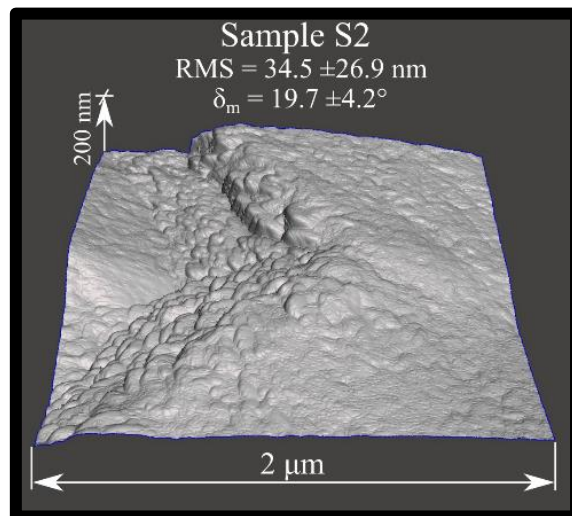
Simulation Approach

**Selected Results and Outlook**

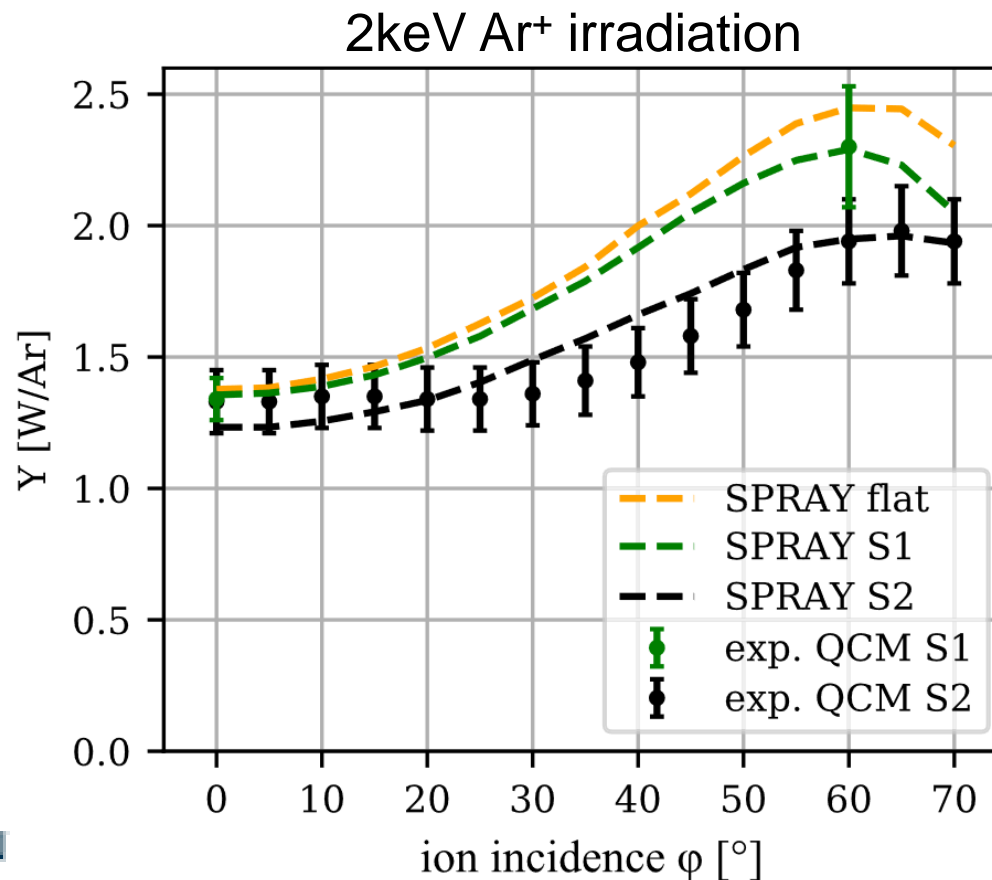
## Gaussian rough surfaces:



smooth sample



comparably rough sample



C. Cupak et al., Appl. Surf. Sci. 570 (2021)

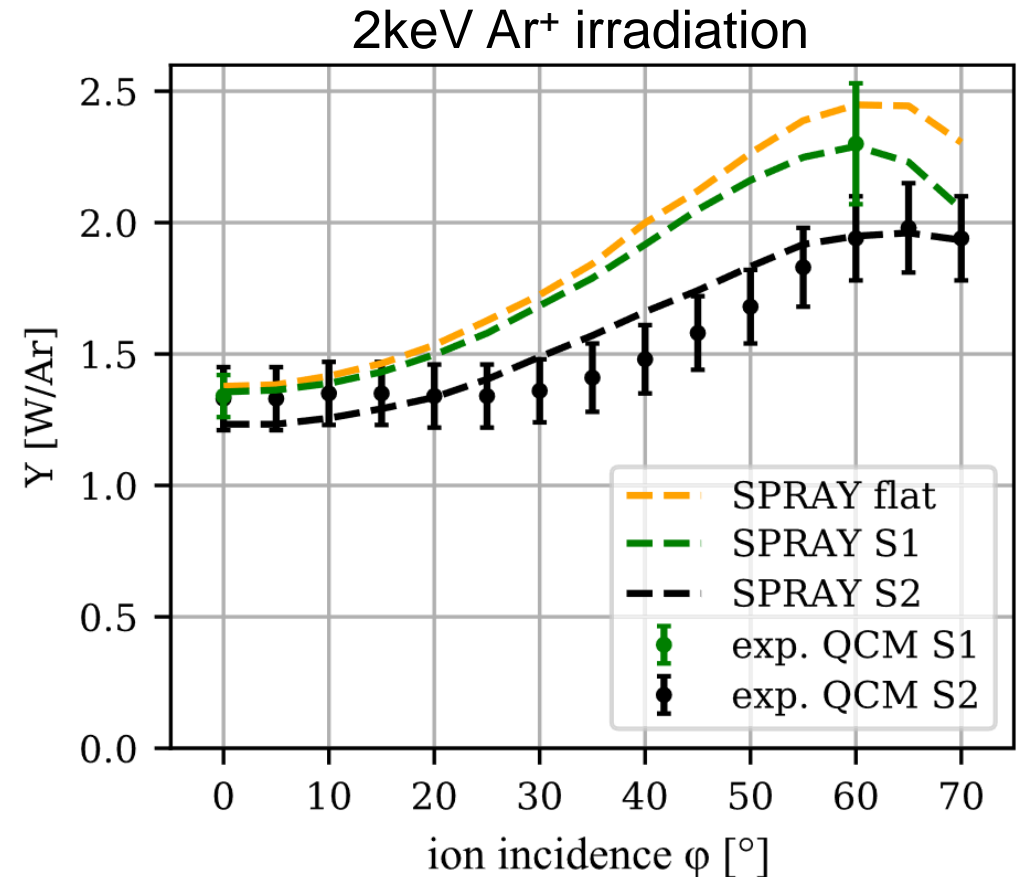
→ sample creation: PVD  
grown at IPP Garching



Max Planck Institut  
for Plasma Physics

## Gaussian rough surfaces:

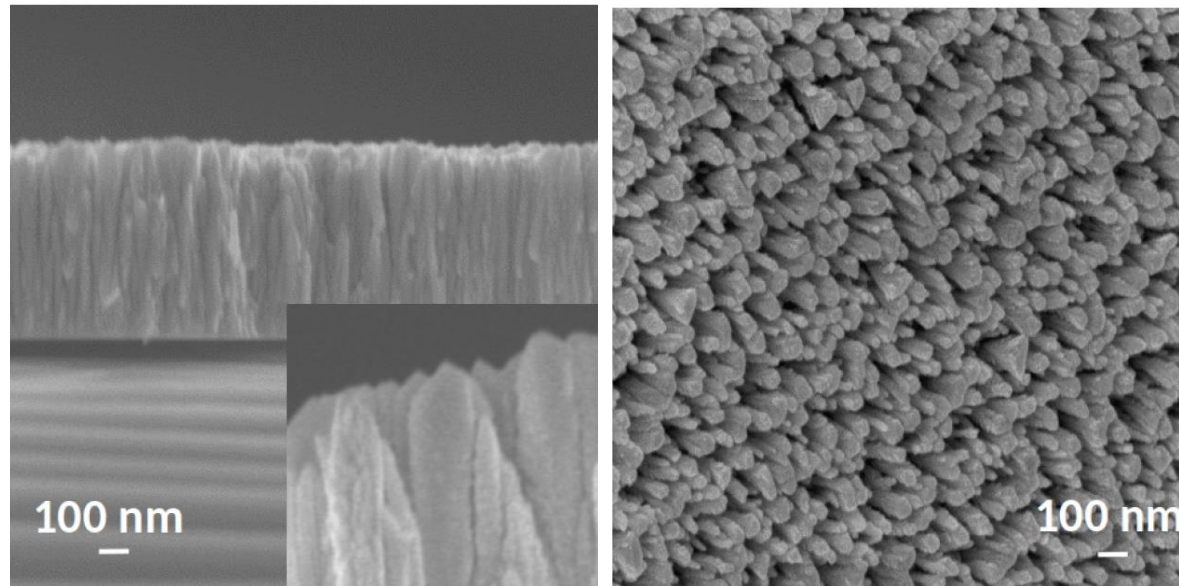
- absolute values of sputter **yields are reduced** due to roughness effects
- angular dependence is smeared out
- results were used to **benchmark SPRAY** code



C. Cupak et al., Appl. Surf. Sci. 570 (2021)

## Nano-columnar surfaces:

sample creation:



Raquel González-Arrabal

A. Lopez-Cazalilla & C. Cupak et al., Phys. Rev. Mater. 6 (2022)



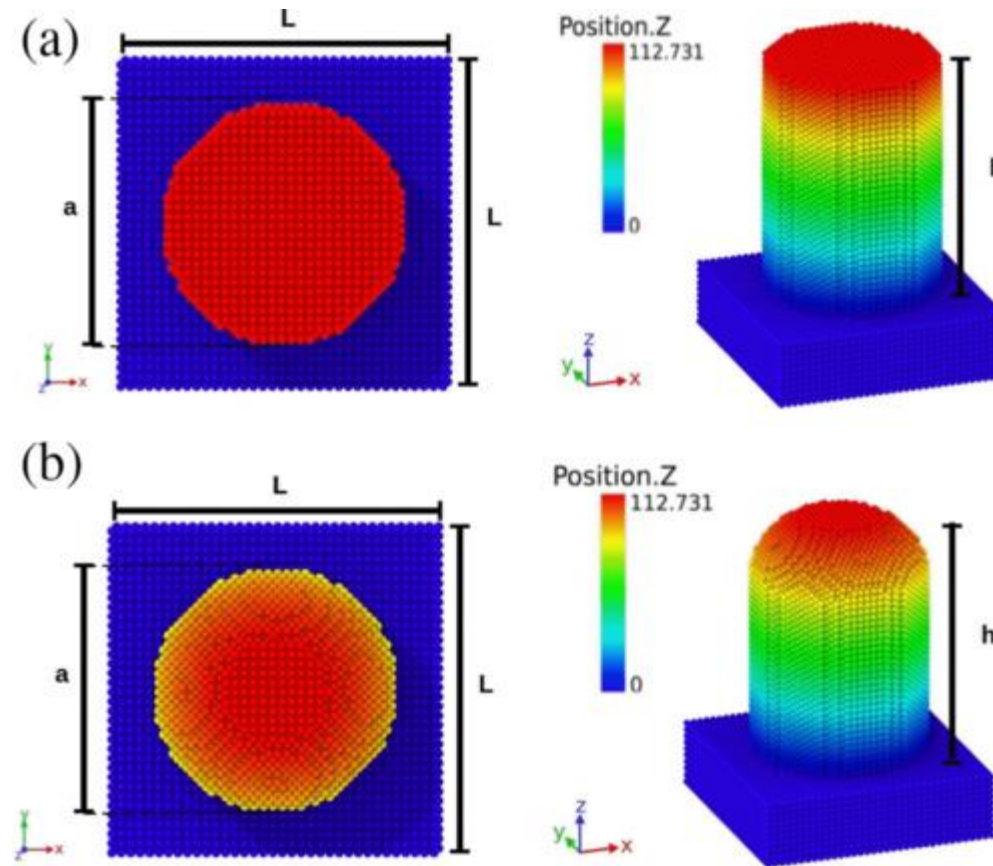
Nano-columnar surfaces:

Molecular dynamics simulations:



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Alvaro Lopez-Cazalilla,  
Fredric Granberg,  
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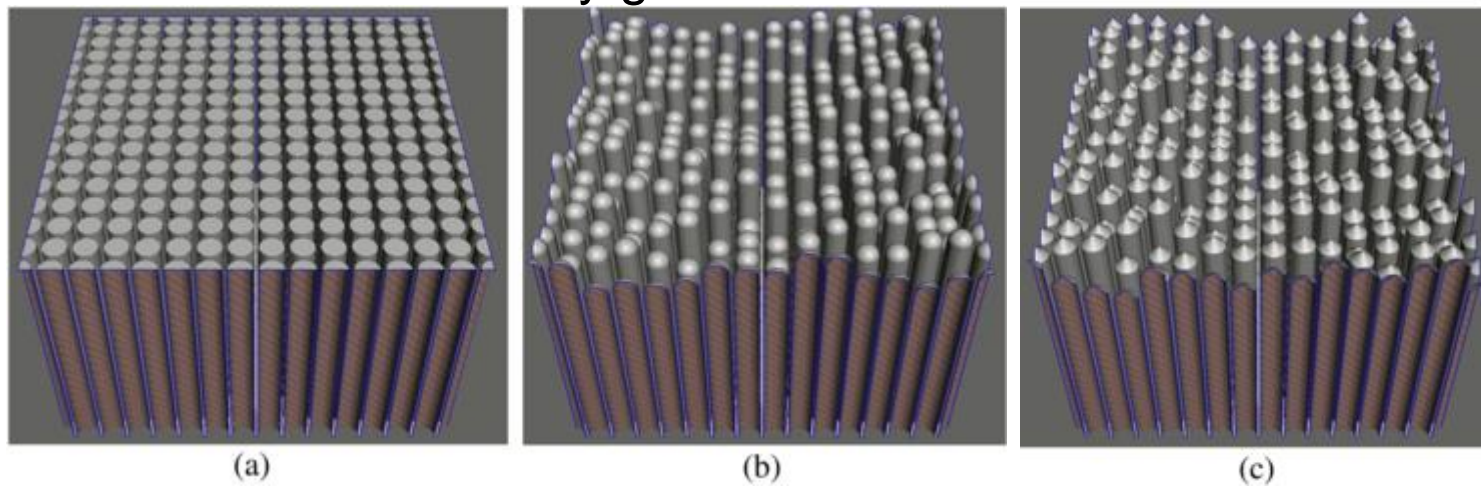


A. Lopez-Cazalilla & C. Cupak et al., Phys. Rev. Mater. 6 (2022)

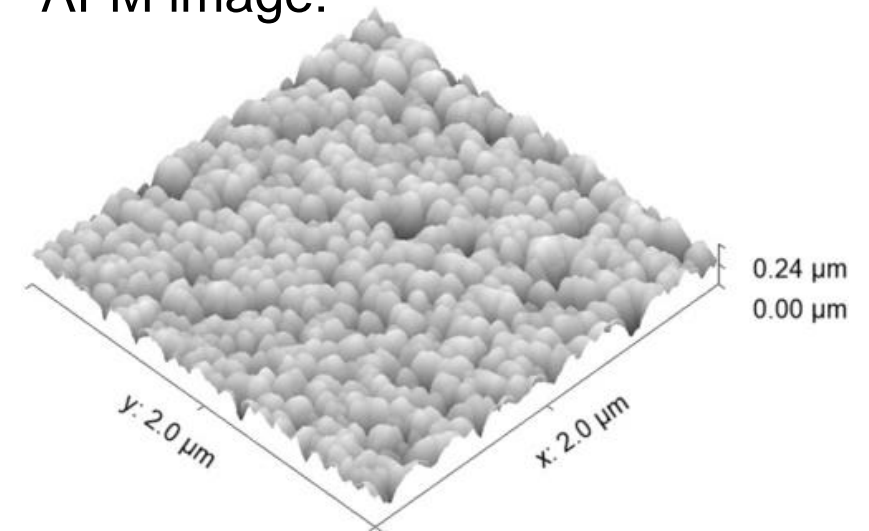
## Nano-columnar surfaces:

SPRAY simulations:

artificially generated structures:



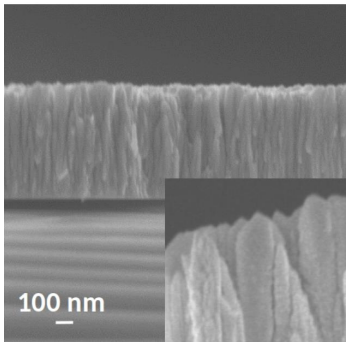
AFM image:



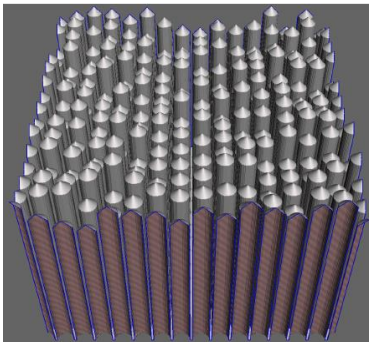
A. Lopez-Cazalilla & C. Cupak et al., Phys. Rev. Mater. 6 (2022)

## Nano-columnar surfaces:

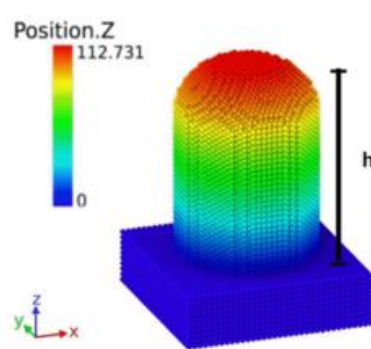
SEM image



SPRAY input



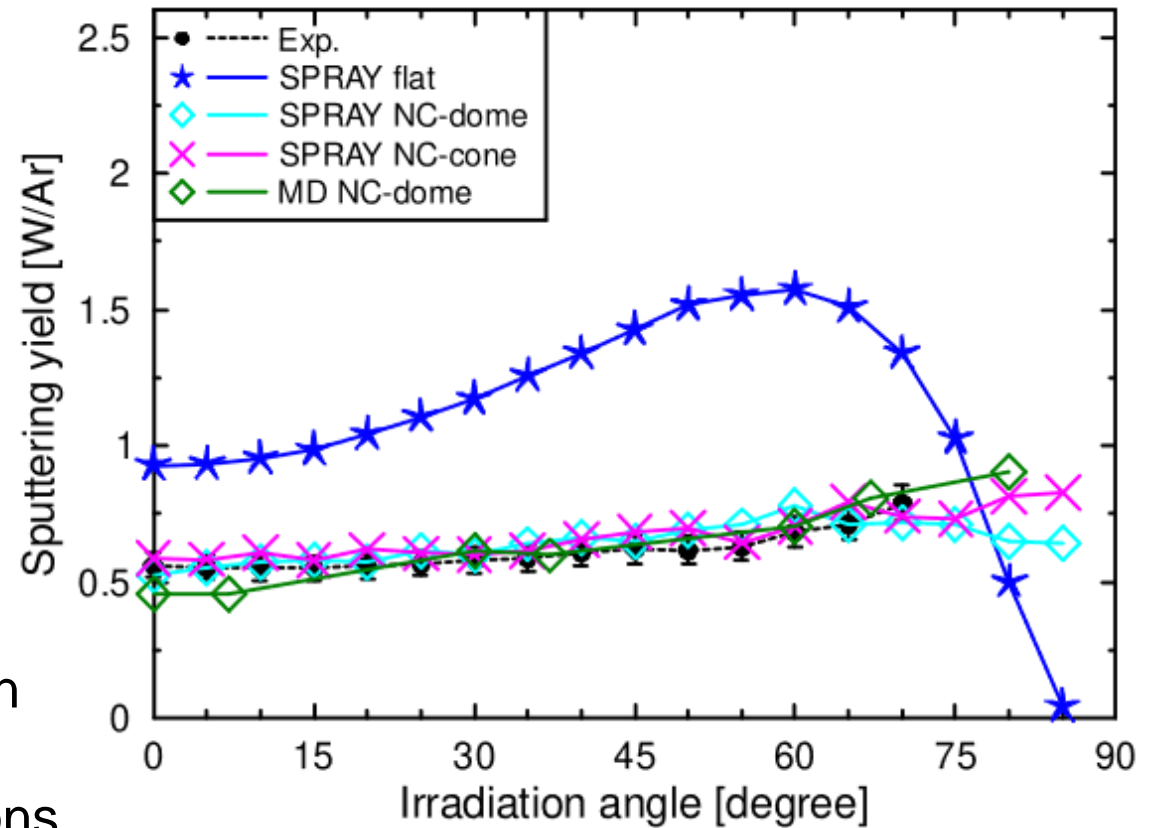
MD input



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→ very good agreement between **experimental** data, **SPRAY** simulations and **MD** Simulations

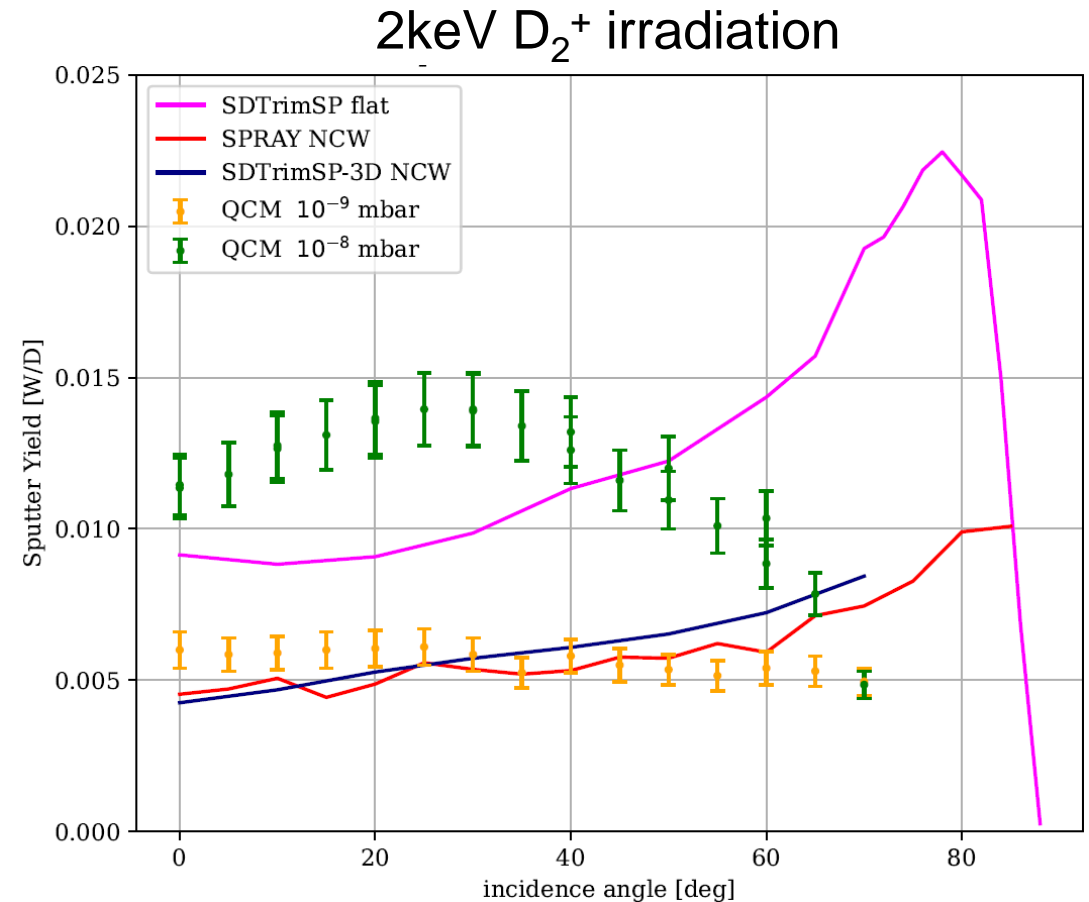
1keV Ar<sup>+</sup> irradiation



A. Lopez-Cazalilla & C. Cupak et al., Phys. Rev. Mater. 6 (2022)

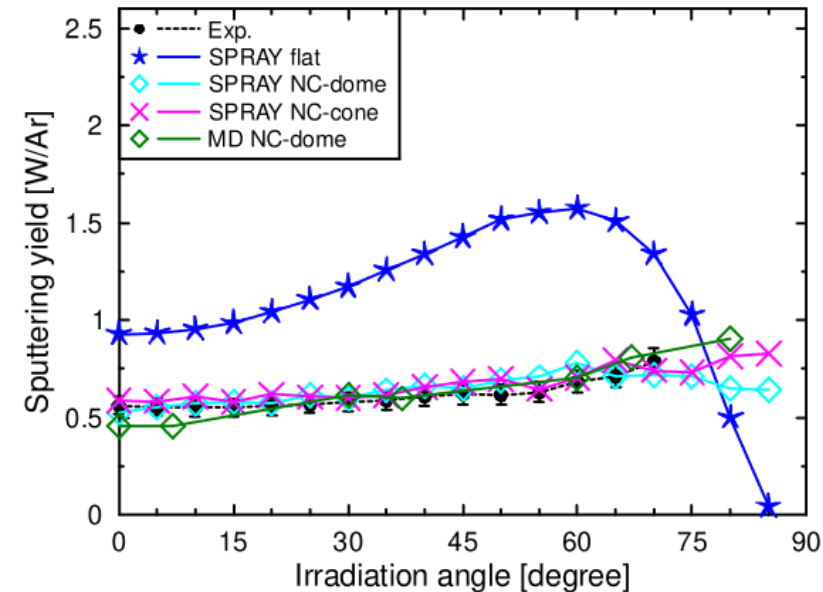
## Nano-columnar surfaces:

- pronounced effect due to residual gas pressure in experimental data
- mass reduction signal represents a convolution of **W sputtering and absorbate sputtering**
- sputter yield reduction due to **geometry effects only** (no particle transmission)



## Nano-columnar surfaces:

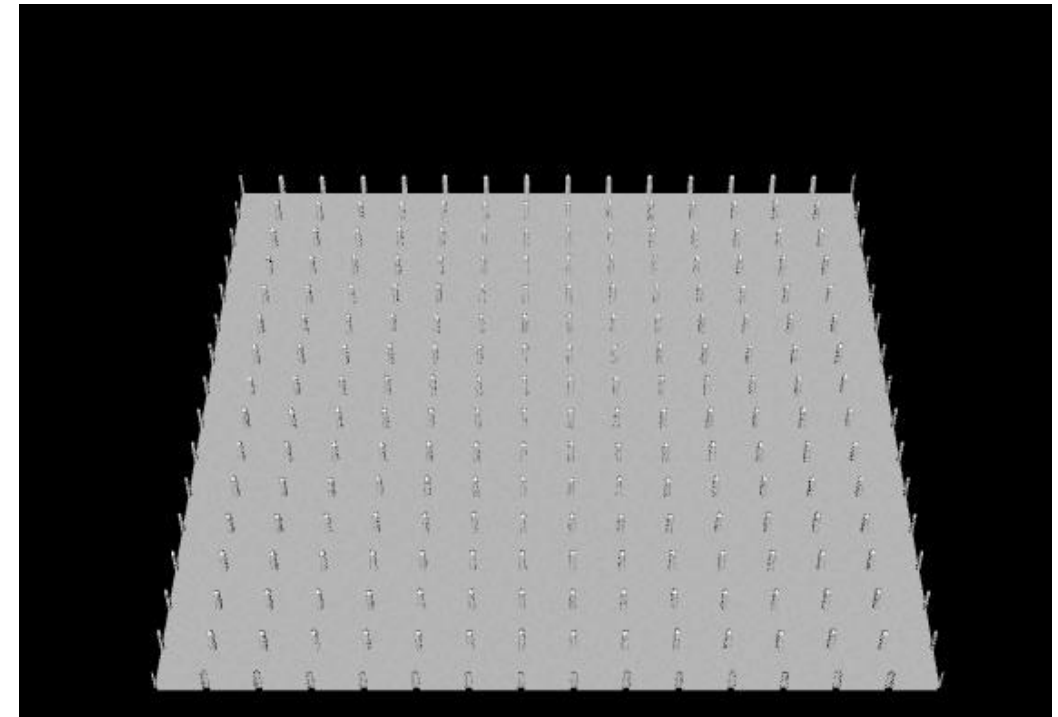
→ can we **optimize** this structure further?



## Nano-columnar surfaces:

→ can we **optimize** this structure further?

- **vary shape parameters** (height, areal density, ...) to minimise sputter yields
- investigate optimized structure in QCM experiments



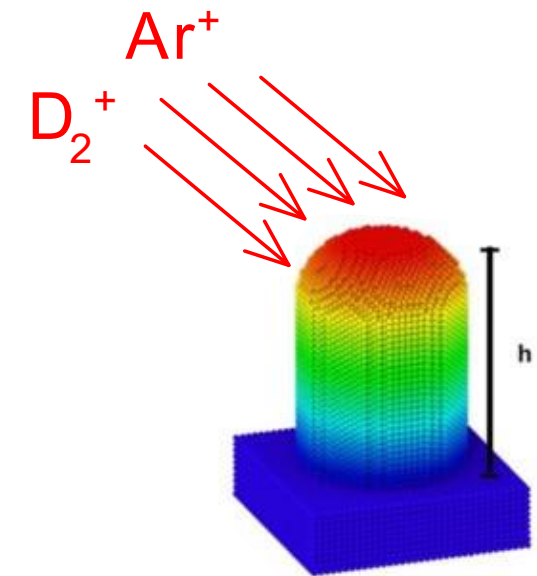
## Nano-columnar surfaces:

→ can we **optimize** this structure further?

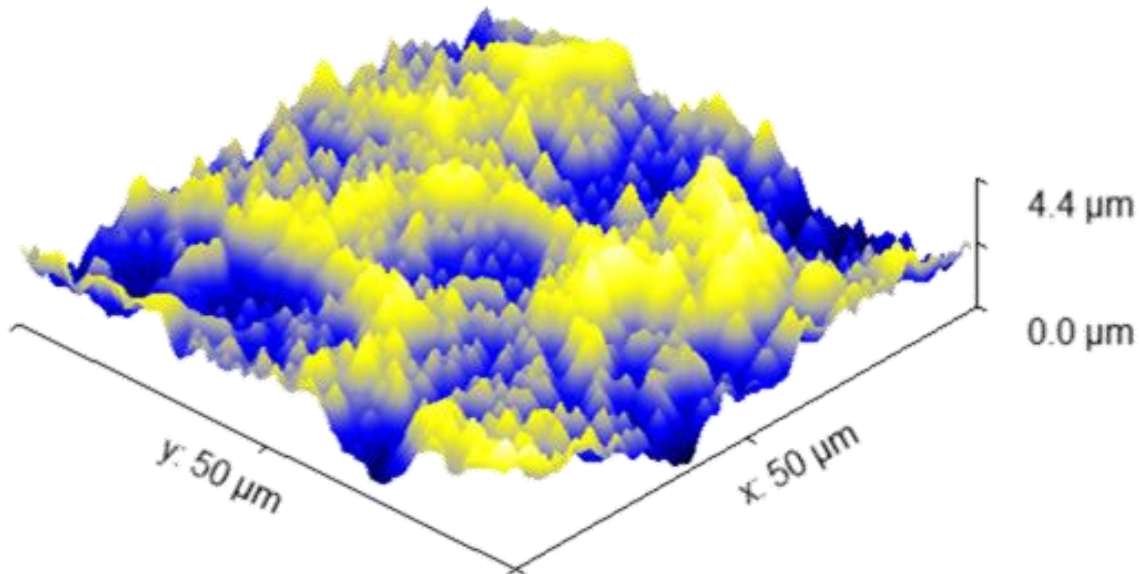
- **vary shape parameters** (height, areal density, ...) to minimise sputter yields
- investigate optimized structure in QCM experiments

→ how **stable** can such a structure be?

- investigate **long term erosion** properties of nano-columns in experiment and simulation



## Pyramidal surfaces:



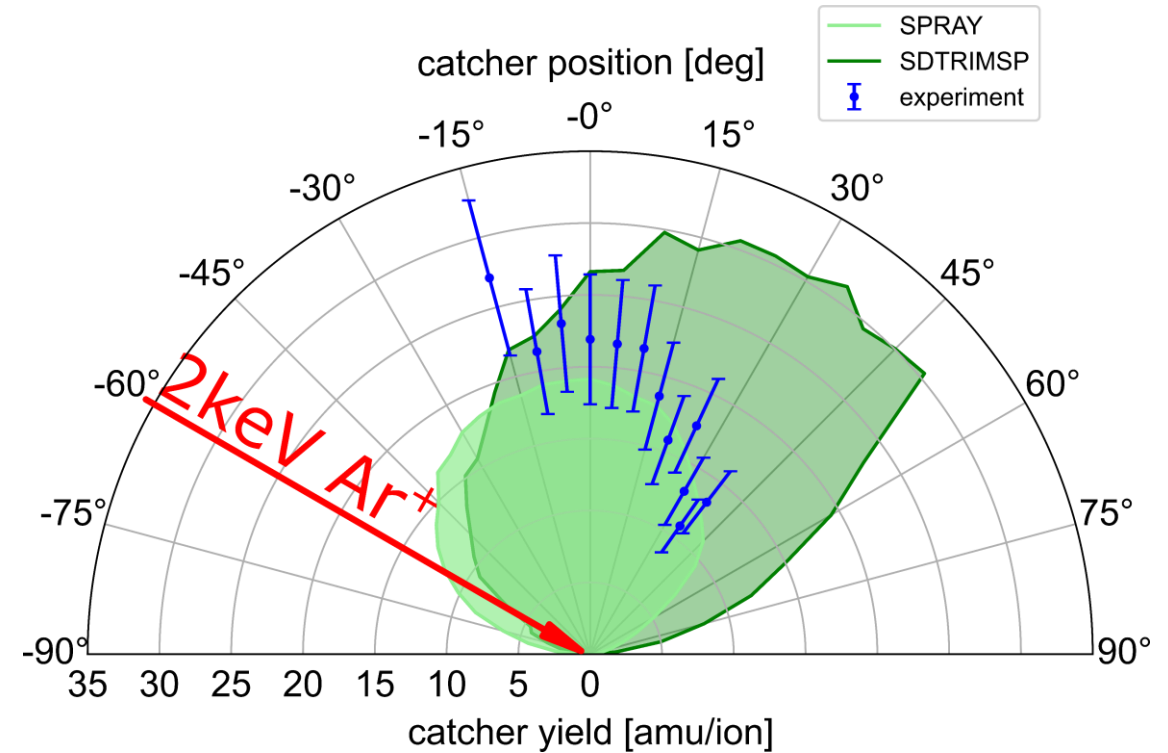
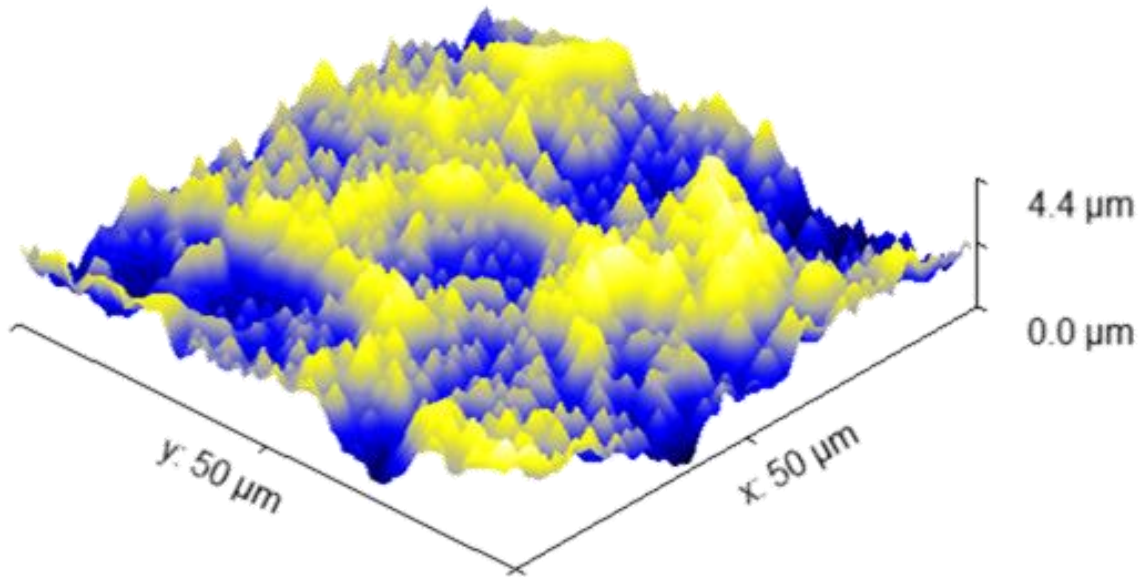
→ **pyramidal W surfaces** grown on Si substrates in Milan

→ surfaces can be investigated with **catcher setup**

→ support experimental data with **numerical simulations**



## Pyramidal surfaces:



Gabriele Alberti, David Dellasega,  
Matteo Passoni, Matteo Pedroni,  
Andrea Uccello, Espedito Vassallo



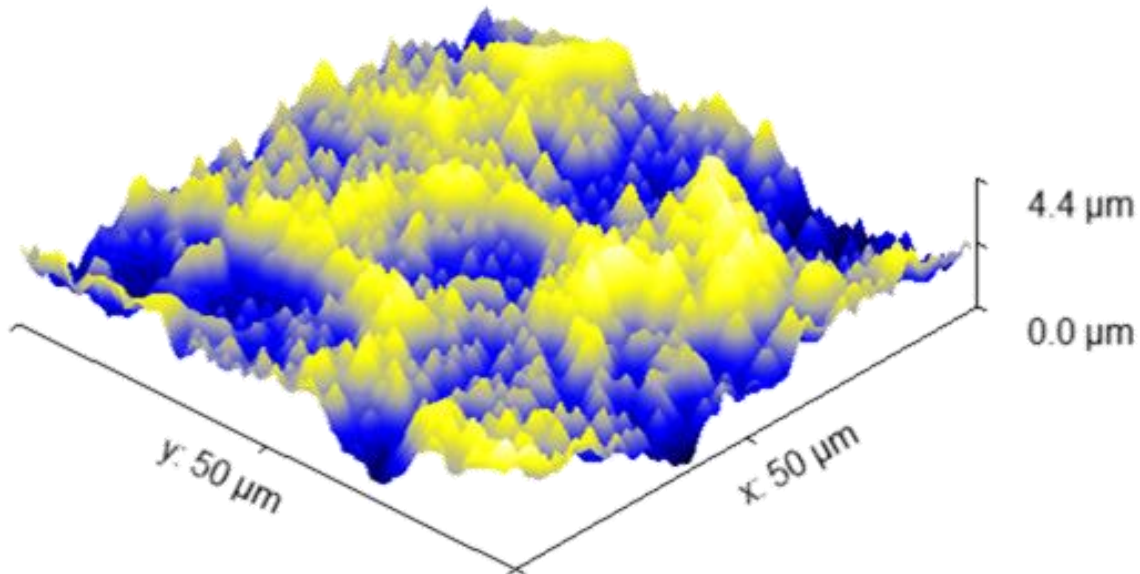
Martina Fellingner

✉ fellinger@iap.tuwien.ac.at  
🌐 <http://www.iap.tuwien.ac.at/www/atomic/>

07.02.2023  
PWIE Kickoff Meeting



## Pyramidal surfaces:



- investigate **different** pyramidal heights
- compare to catcher data for flat surfaces
- investigate how **sputtering into the direction of the ion beam** is triggered

## Re-deposited surfaces:

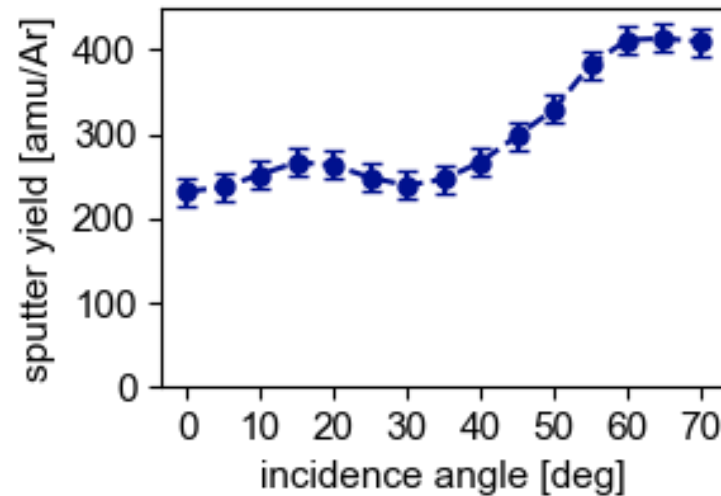
original W sample:



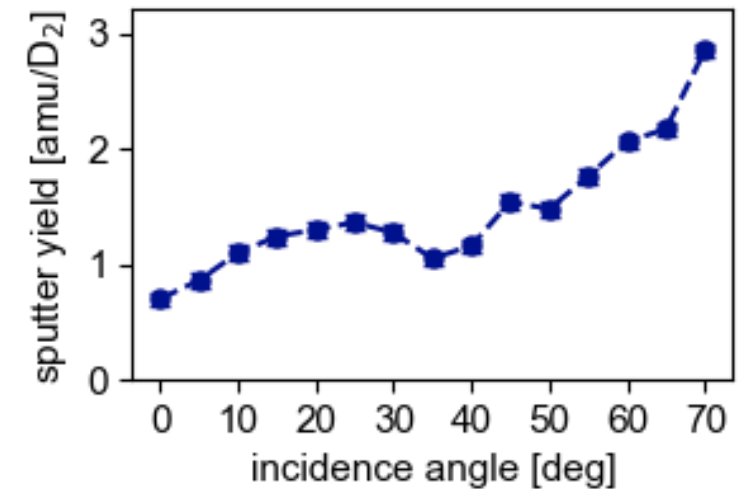
→ sample creation:  
PVD - grown at  
IPP Garching



2keV Ar<sup>+</sup> irradiation



2keV D<sub>2</sub><sup>+</sup> irradiation

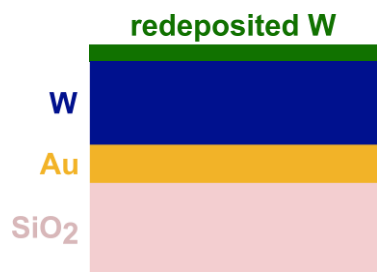


## Re-deposited surfaces:

original W sample:

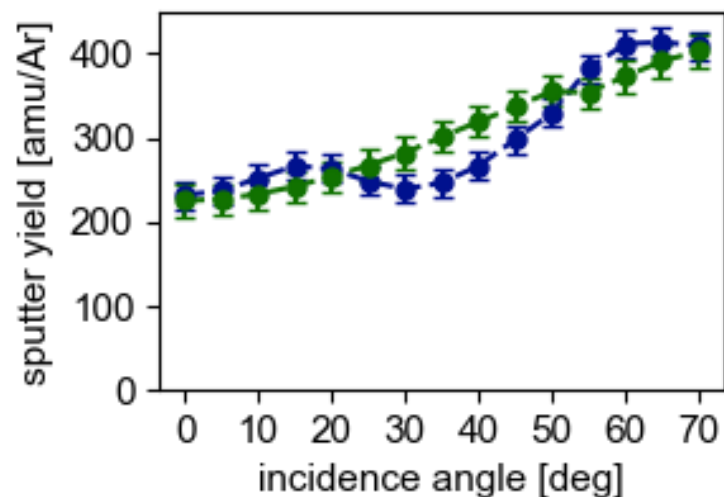


redeposited W sample:

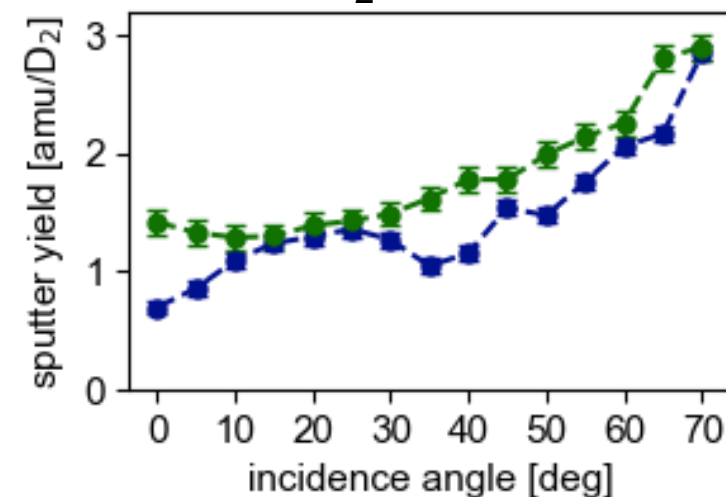


→ sample creation: sputter coating at TU WIEN

2keV Ar<sup>+</sup> irradiation



2keV D<sub>2</sub><sup>+</sup> irradiation

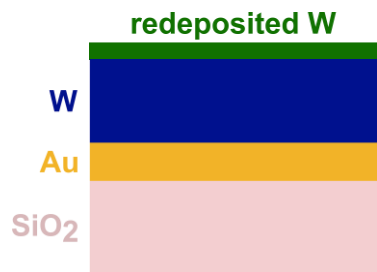


## Re-deposited surfaces:

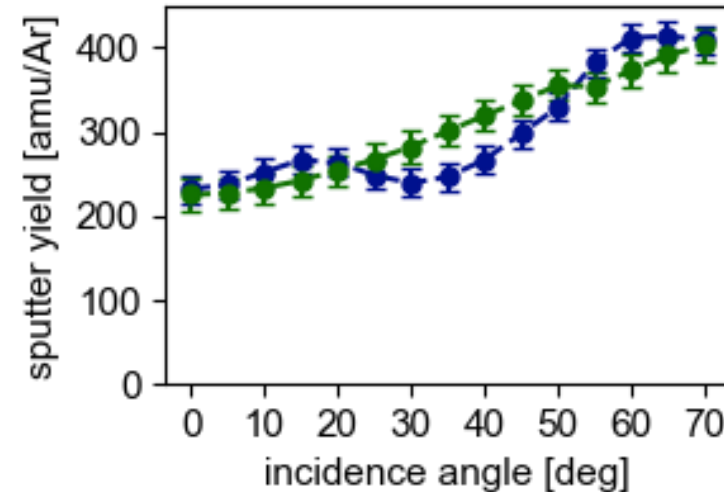
original W sample:



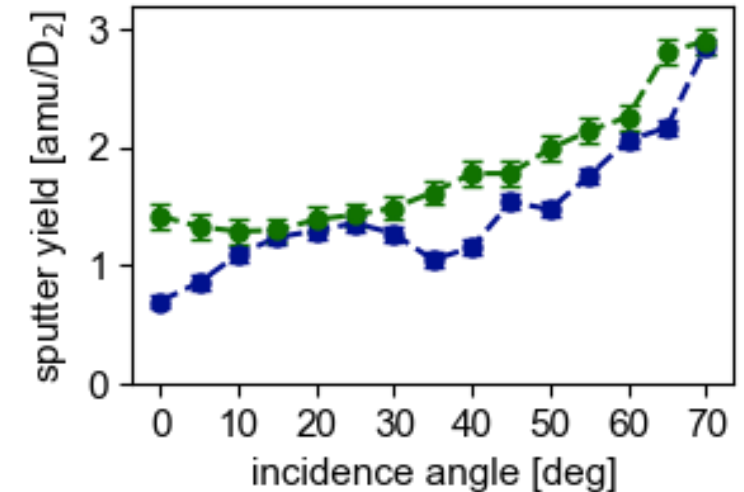
re-deposited W sample:



2keV Ar<sup>+</sup> irradiation



2keV D<sub>2</sub><sup>+</sup> irradiation

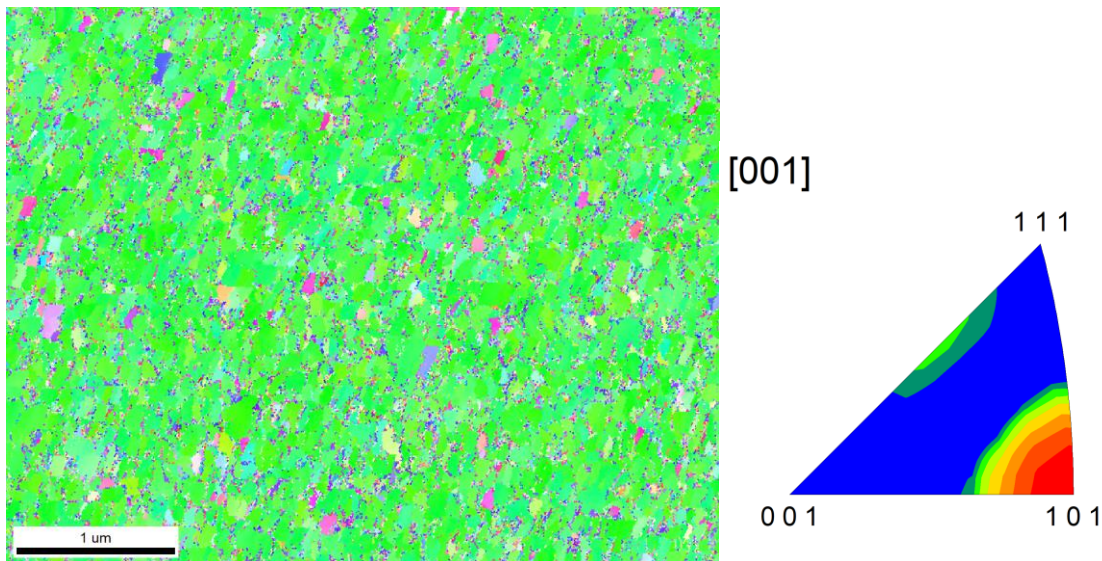


- absolute sputter yield values of re-deposited and original layers are comparable
- **local minimum** found in original W layers
- minimum not visible any more for re-deposited layers

**TEXTURE  
EFFECTS?**

## TEXTURE EFFECTS?

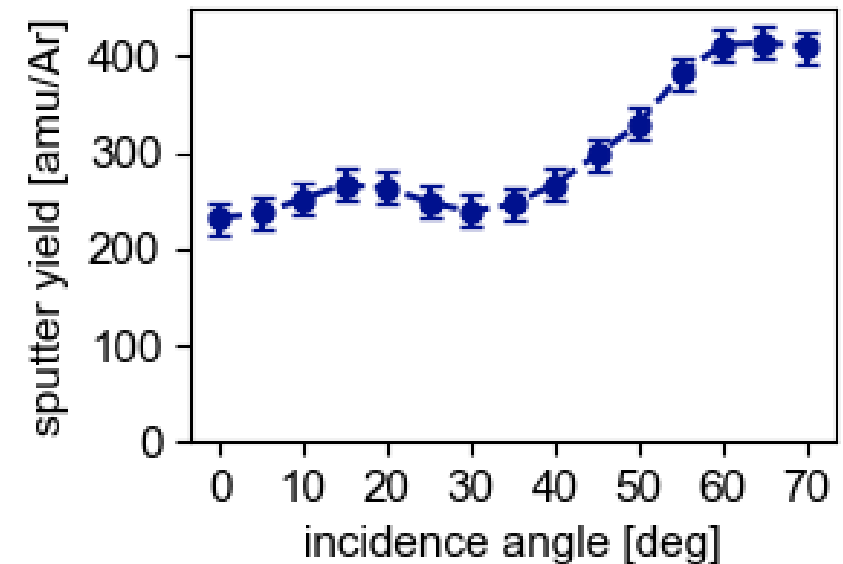
EBSD map of representative Fe QCM sample:



- ions can penetrate deeper into the material for specific incidence angles
- collision cascade is triggered at higher depths
- amount of **effectively sputtered particles** can be **reduced**

## Surfaces with specific textures:

- **crystallographic features** seen in previous samples
- check on minima and maxima in angular dependent sputter yields and if they correlate with **specific crystallographic orientations**
- investigate different **materials**, different **projectiles** with variable **energies**
- investigate also **emission characteristics** of sputtered particles for various textures



TEXTURE  
EFFECTS?

